

Application/Control	No.
10/521,819	

Examiner

Allen J. Flanigan

Applicant(s)/Patent under Reexamination SHINCHO ET AL.

Art Unit 3744

	ORIG	INAL		ı	INTERNATIONAL CLASSIFICATION										
	CLASS	CLASS			CL	AIMED		NON-CLAIMED							
	165 .	3	F	28	D	7	/10			1					
	F	28	F	9	/22			,							
CLASS	SUBCLASS (C	NE SUBCLASS P	R BLOCK)	<u> </u>		$\longrightarrow$									
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(Assi	stant Examiner)	(Date)	Allen J.	Flan	2 igan	6/20	M 12007	em	, Total C	laims Allow	ed: 2				
(Primary E. (Legal Instruments Examiner) (Date)					ner)		(Date)		O.G. Print Fi						

$\boxtimes$ c	laims										□СРА			☐ T.D.			☐ R.1.47		
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1			31			61			91			121			151			181
	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
	6			36			66			96			126			156			186
	7			37			67			97			127			157			187
	8			38	•		68			98			128			158			188
	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11	.		41			71			101			131			161			191
	12			42			72			102			132			162			192
	13			43			73			103			133			163			193
	14			44			74			104			134			164	j		194
	15	-[		45			75			105			135			165			195
	16			46			76			106			136			166			196
	17			47			77			107			137			167			197
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	21			51			81			111	ĺ		141			171			201
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	25			55			85			115			145			175			205
	26			56			86			116			146			176			206
	27			57			87			117			147			177			207
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